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EXPEDITED PROCEDURE – EXAMINING GROUP 2857

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Sergey A. Velichko et al. Examiner: Craig Steven Miller
Serial No.: 09/834,751 Group Art Unit: 2857
Filed: April 13, 2001 Docket No.: 303.750US1
Title: CONCURRENT CONTROL OF SEMICONDUCTOR PARAMETRIC
TESTING

RESPONSE UNDER 37 C.F.R. 1.116

Mail Stop AF
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

In response to the Final Office Action mailed November 8, 2004, please consider the following:

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Commissioner for Patents

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We are transmitting herewith the following attached items (as indicated with an "X"):

A return postcard.
 Response Under 37 CFR 1.116 (15 Pages).

If not provided for in a separate paper filed herewith, Please consider this a PETITION FOR EXTENSION OF TIME for sufficient number of months to enter these papers and please charge any additional fees or credit overpayment to Deposit Account No. 19-0743.

SCHWEGMAN, LUNDBERG, WOESSNER & KLUTH, P.A.

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CERTIFICATE UNDER 37 CFR 1.8: The undersigned hereby certifies that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail, in an envelope addressed to: MS AF, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450, on this 10 day of January, 2005.

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(GENERAL)